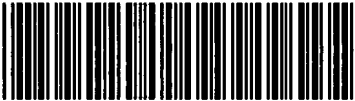


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599894	<b>Applicant(s)/Patent Under Reexamination</b>  MAINWARING ET AL.
	<b>Examiner</b>  Dunlap, Jonathan	<b>Art Unit</b>  2855

SEARCHED			
Class	Subclass	Date	Examiner
73	777	9/17/2007	JD
427		9/17/2007	JD

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search	9/17/2007	JD
Class/Subclass Search	9/17/2007	JD
Text Search	9/17/2007	JD
Google NPL Search (ion polyimide strain sensor fluence)	9/16/2007	JD
Forward and Backward Citation of Relevant Art	9/16/2007	JD
JPO Abstracts (polyimide ion strain)	9/16/2007	JD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner